

TEST REPORT

Report No.:	8255EU012212W			
Applicant:	Hong Kong Etech Groups Ltd.			
Address:	16/F, Block C,2nd Phase of Central Avenue,Haihong Industrial Area,Xixiang,Baoan,Shenzhen,China			
Product Name:	True Wireless Earbuds			
Model No.:	EB5608 (refer to clause 2.4)			
Trademark:	N/A			
FCC ID:	2A3ZO-21945			
Test Standard(s):	47 CFR Part 15 Subpart C			
Date of Receipt:	Jan. 22, 2024			
Test Date:	Jan. 22, 2024 - Jan. 27, 2024			
Date of Issue:	Feb. 19, 2024			

ISSUED BY: SHENZHEN EU TESTING LABORATORY

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Revision Record

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Address: 101, Building B1, Fuqiao Fourth Area, Qiaotou Community, Fuhai Subdistrict, Baoan District, Shenzhen, Guangdong, China



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2 General Information

2.1 Applicant Information

Applicant	Hong Kong Etech Groups Ltd.	
Address	16/F, Block C,2nd Phase of Central Avenue,Haihong Industrial Area,Xixiang,Baoan,Shenzhen,China	

2.2 Manufacturer Information

Manufacturer Hong Kong Etech Groups Ltd.	
Address	16/F, Block C,2nd Phase of Central Avenue,Haihong Industrial Area,Xixiang,Baoan,Shenzhen,China

2.3 Factory Information

Factory	Hong Kong Etech Groups Ltd.		
Address	16/F, Block C,2nd Phase of Central Avenue,Haihong Industrial Area,Xixiang,Baoan,Shenzhen,China		

2.4 General Description of E.U.T.

Product Name	True Wireless Earbuds			
Model No. Under Test	EB5608			
List Model No.	EBT4-21501, EB5608-PUA, EB5608-CRM, EB5608-WHT			
Description of Model differentiation	All models are same with electrical parameters and internal circuit structure, but only differ in model name. (this information provided by the customer)			
Rating(s)	Input: 5VDC, 300mA Battery Capacity: 3.7VDC, 30mAh			
Product Type	 ☐ Mobile ➢ Portable ☐ Fix Location 			
Test Sample No.	-1/1(Normal Sample)			
Hardware Version	N/A			
Software Version	N/A			
Remark	 For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual. The EUT is a TWS bluetooth symmetrical headset, and since the internal structure of the left and right headphones are the same, so only the worst case is recorded in the report (left ear). 			

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2.5 Technical Information of E.U.T.

Technology Used	Bluetooth (BDR+EDR)
roomiology ocou	

The requirement for the following technical information of the EUT was tested in this report:

Technology	Bluetooth		
Operation Mode	⊠ BDR ⊠ EDR		
Modulation Type	GFSK, π/4DQPSK, 8DPSK		
Operating Frequency	2402-2480MHz		
Transfer Rate	DH5: 1 Mbps 2DH5: 2 Mbps 3DH5: 3 Mbps		
Number of Channel	79		
Antenna Type	PCB Antenna		
Antenna Gain(Peak)	-1.2 dBi		

All channel was listed on the following table:

Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.
Number	(MHz)	Number	(MHz)	Number	(MHz)	Number	(MHz)
0	2402	21	2423	42	2444	63	2465
1	2403	22	2424	43	2445	64	2466
2	2404	23	2425	44	2446	65	2467
3	2405	24	2426	45	2447	66	2468
4	2406	25	2427	46	2448	67	2469
5	2407	26	2428	47	2449	68	2470
6	2408	27	2429	48	2450	69	2471
7	2409	28	2430	49	2451	70	2472
8	2410	29	2431	50	2452	71	2473
9	2411	30	2432	51	2453	72	2474
10	2412	31	2433	52	2454	73	2475
11	2413	32	2434	53	2455	74	2476
12	2414	33	2435	54	2456	75	2477
13	2415	34	2436	55	2457	76	2478
14	2416	35	2437	56	2458	77	2479
15	2417	36	2438	57	2459	78	2480
16	2418	37	2439	58	2460	-	-
17	2419	38	2440	59	2461	-	-
18	2420	39	2441	60	2462	-	-
19	2421	40	2442	61	2463	-	-
20	2422	41	2443	62	2464	-	-

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3 Test Summary

3.1 Test Standard

The tests were performed according to following standards:

No.	Identity	Document Title
1	47 CFR Part 15, Subpart C	Intentional radiators of radio frequency equipment
2	ANSI C63.10-2020	American National Standard for Testing Unlicensed Wireless Devices
3	KDB 558074 D01 15.247 Meas Guidance v05r02	Guidance for compliance measurements on digital transmission system, frequency hopping spread spectrum system, and hybrid system devices operating under section 15.247 of the FCC rules

Remark:

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product maybe which result in lowering the emission/immunity should be checked to ensure compliance has been maintained.

3.2 Test Verdict

No.	Description	FCC Part No.	Channel	Verdict	Remark
1	Antenna Requirement	15.203	N/A	Pass	Note ¹
2	Conducted Emission at AC Power Line	15.207	Low/Middle/High	Pass	
3	Occupied Bandwidth	15.215(c)	Low/Middle/High	Pass	
4	Maximum Conducted Output Power	15.247(b)(1)	Low/Middle/High	Pass	
5	Carrier Frequency Separation	15.247(a)(1)	Hopping Mode	Pass	
6	Number of Hopping Frequencies	15.247(a)(1) (iii)	Hopping Mode	Pass	
7	Time of Occupancy (Dwell time)	15.247(a)(1)(iii)	Hopping Mode	Pass	
8	Emission in non-restricted frequency bands (Conducted)	15.247(d)	Hopping Mode; Low/Middle/High	Pass	
9	Band Edge Emissions (Restricted frequency bands)	15.209 15.247(d)	Low/High	Pass	
10	Radiated Spurious Emission	Spurious Emission 15.209 15.247(d) Low/Middle/High		Pass	
Note ¹	1: The EUT has a permanently and it	roplaceable attached	antonna which comp	lice with the	roquiromont

Note ¹: The EUT has a permanently and irreplaceable attached antenna, which complies with the requirement FCC 15.203.

3.3 Test Laboratory

Test Laboratory	Shenzhen EU Testing Laboratory Limited			
Address	1/F, Bldg. B1, Fuqiao Fourth Industrial Area, Fuhai Street, Baoan District, Shenzhen, Guangdong, China			
Designation Number	CN1368			
Test Firm Registration Number	952583			

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4 Test Configuration

4.1 Test Environment

During the measurement, the normal environmental conditions were within the listed ranges:

Relative Humidity	40% to 60%	
Atmospheric Pressure	90 kPa to 102 kPa	
Temperature	NT (Normal Temperature)	+15℃ to +35℃
Working Voltage of the EUT	NV (Normal Voltage)	3.7V

4.2 Test Equipment

Conducted Emission at AC power line								
Equipment	Manufacturer	Model No	Serial No	Cal Date	Cal Due Date			
L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	EE-004	2024/01/09	2025/01/08			
EMI Test Receiver	Rohde & Schwarz	ESCI	EE-005	2024/01/09	2025/01/08			
Test Software	Farad	EZ-EMC	EE-014	N.C.R	N.C.R			

Radiated Emission and RF Test						
Equipment	Manufacturer	Model No	Serial No	Cal. Date	Cal. Due Date	
EMI Test Receiver	ROHDE & SCHWARZ	ESPI	EE-006	2024/01/09	2025/01/08	
Bilog Broadband Antenna	SCHWARZBECK	VULB 9163	EE-007	2023/01/14	2026/01/09	
Double Ridged Horn Antenna	A-INFOMW	LB-10180-NF	EE-008	2023/01/12	2026/01/09	
Pre-amplifier	Agilent	8447D	EE-009	2024/01/09	2025/01/08	
Pre-amplifier	Agilent	8449B	EE-010	2024/01/09	2025/01/08	
MXA Signal Analyzer	Agilent	N9020A	EE-011	2024/01/09	2025/01/08	
MXG RF Vector Signal Generator	Agilent	N5182A	EE-012	2024/01/09	2025/01/08	
Test Software	Farad	EZ-EMC	EE-015	N.C.R	N.C.R	
MIMO Power Measurement Module	TSTPASS	TSPS 2023R	EE-016	2023/05/17	2024/05/16	
RF Test Software	TSTPASS	TS32893 V2.0	EE-017	N.C.R	N.C.R	
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	EE-402	2023/02/16	2024/02/15	
Loop Antenna	TESEQ	HLA6121	EE-403	2023/02/16	2024/02/15	
MXG RF Analog Signal Generator	Agilent	N5181A	EE-406	2023/02/16	2024/02/15	
Power Meter	Anritsu	ML2495A	EE-416	2023/06/07	2024/06/06	
Constant Temperature Humidity Chamber	Guangxin	GXP-401	ES-002	2023/07/31	2024/07/30	

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4.3 Description of Support Unit

	No.	Title	Manufacturer	Model No.	Serial No.
	1	Adapter	MI	A232-050200U-CN2	
Ī	2	Mobile phone	Apple	iphone 13	

4.4 Test Mode

No.	Test Modes	Description
TM1	TX-GFSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with GFSK modulation.
TM2	TX-GFSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with GFSK modulation.
ТМ3	TX-π/4DQPSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with π /4DQPSK modulation.
TM4	TX-π/4DQPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with π /4DQPSK modulation.
TM5	TX-8DPSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with 8DPSK modulation.
TM6	TX-8DPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with 8DPSK modulation.

4.5 Measurement Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2.

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test Item	Measurement Uncertainty					
Conducted Emission	2.64 dB					
Occupied Channel Bandwidth	2.8 %					
RF output power, conducted	0.68 dB					
Power Spectral Density, conducted	1.37 dB					
Unwanted Emissions, conducted	1.84 dB					
Radiated Emission	Ur = 2.70 dB (Horizontal)					
(30MHz- 1GHz)	Ur = 2.70 dB (Vertical)					
Radiated Emission	Ur = 3.50 dB (Horizontal)					
(1GHz- 18GHz)	Ur = 3.50 dB (Vertical)					
Radiated Emission	Ur = 5.15 dB (Horizontal)					
(18GHz- 40GHz)	Ur = 5.24 dB (Vertical)					
Temperature	0.8°C					
Humidity	4%					

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4.6 Deviation from Standards

None.

4.7 Abnormalities from Standard Condition

None.



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TRF No.: FCC Part 15.247_BT (B01)

Website: www.eu-test.com Tel: (86)-755-2357-9714 Email: Service@eu-test.com



5 Test Items

5.1 Antenna requirement

5.1.1 Test Requirement

	shall be considered sufficient to comply with the FCC rule.
	directional gain of the antenna exceeds 6 dBi. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator
	reduced by the same level in dB comparing to gain minus 6 dBi. For the fixed point- to-point operation, the power shall be reduced by one dB for every 3 dB that the
	If directional gain of transmitting antennas is greater than 6 dBi, the power shall be
	installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this part are not exceeded.
	radiators which, in accordance with § 15.31(d), must be measured at the
Test Requirement	protection systems and some field disturbance sensors, or to other intentional
	§ 15.217, § 15.219, or § 15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter
	current devices or to devices operated under the provisions of § 15.211, § 15.213,
	jack or electrical connector is prohibited. This requirement does not apply to carrier
	with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna
	a unique coupling to the intentional radiator shall be considered sufficient to comply
	the device. The use of a permanently attached antenna or of an antenna that uses
	no antenna other than that furnished by the responsible party shall be used with
	According to FCC §15.203, an intentional radiator shall be designed to ensure that

5.1.2 Antenna Anti-Replacement Construction

The Antenna Anti-Replacement as following method:

Protected Method	Description				
The antenna is embedded in the product.	An embedded-in antenna design is used.				

5.1.3 Antenna Gain

The antenna peak gain of EUT is less than 6 dBi. Therefore, it is not necessary to reduce maximum peak output power limit.

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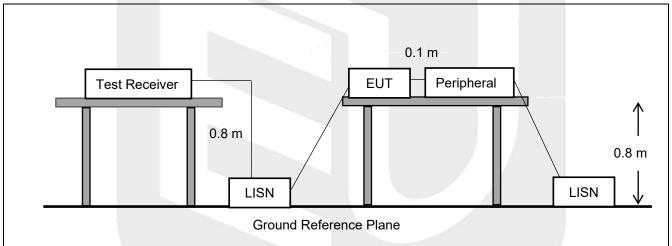


5.2 Conducted Emission at AC Power Line

5.2.1 Test Requirement

Test Requirement:	Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 µH/50 ohms line impedance stabilization network (LISN).				
	Frequency of emission (MHz)	Conducted limit (dBµV)			
		Quasi-peak	Average		
	0.15-0.5	66 to 56*	56 to 46*		
Test Limit	0.5-5	56	46		
	5-30	50			
	*Decreases with the logarithm of the frequency.				
Test Method	Refer to ANSI C63.10-2020 section conducted emissions from unlicens		l for ac power-line		

5.2.2 Test Setup Diagram



5.2.3 Test Procedure

The EUT is put on the plane 0.8 m high above the ground by insulating support and connected to the AC mains through Line Impedance Stability Network (L.I.S.N). This provided a 50ohm coupling impedance for the tested equipment. Both sides of AC line are investigated to find out the maximum conducted emission according to the test standard regulations during conducted emission measurement.

The bandwidth of the field strength meter (R&S Test Receiver ESCI) is set at 9kHz in 150kHz~30MHz. The maximum conducted interference is searched using Peak (PK), if the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. Refer to recorded points and plots below.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.2.4 Test Data

PASS.

Only the worst case data was showed in the report, please to see the following pages.

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Conducted Emission Test Data

Fest Si	te:		Sh	nielded R	oom #1					
est M	ode:		TN	/12/ CH M	iddle					
Comme	ents:		Liv	/e Line						
80	.0 dBuV									
70										
60								FCC	Pait15 CE-Class B_QP	
50								FCC	Pait15 CE-Class B_AVG	
40			×							_
30		$\psi^{\alpha}\psi^{\alpha}\psi^{\alpha}\psi^{\alpha}\psi^{\alpha}\psi^{\alpha}\psi^{\alpha}\psi^{\alpha}$		Windowww	z huh "mint			www.	11 marthyle-buryling have	
20	Y/	MM	V V	Marian		$\overline{\mathbf{v}}$		ŶŴ	WWW mannen	peak
10 0	.0			- Y - W*F						AVG
	0.150	0	.500		(MHz)		5.000			30.000
No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark	
1	0.1635	32.00	9.91	41.91	65.28	-23.37	QP	Р		
2	0.1635	13.62	9.91	23.53	55.28	-31.75	AVG	Р		
3	0.2445	29.34	9.92	39.26	61.94	-22.68	QP	Р		
4	0.2445	10.87	9.92	20.79	51.94	-31.15	AVG	Р		
5 *	0.7665	33.67	9.99	43.66	56.00	-12.34	QP	Р		
6	0.7665	21.49	9.99	31.48	46.00	-14.52	AVG	Р		
7	2.5305	18.65	10.00	28.65	56.00	-27.35	QP	Р		
_	0.5005	0.00	40.00	40.00	40.00	00 77	AV (0			

110.	(MHz)	(dBuV)	(dB)	(dBuV)	(dBuV)	(dB)	Detector		Remark
1	0.1635	32.00	9.91	41.91	65.28	-23.37	QP	Ρ	
2	0.1635	13.62	9.91	23.53	55.28	-31.75	AVG	Ρ	
3	0.2445	29.34	9.92	39.26	61.94	-22.68	QP	Р	
4	0.2445	10.87	9.92	20.79	51.94	-31.15	AVG	Ρ	
5 *	0.7665	33.67	9.99	43.66	56.00	-12.34	QP	Р	
6	0.7665	21.49	9.99	31.48	46.00	-14.52	AVG	Ρ	
7	2.5305	18.65	10.00	28.65	56.00	-27.35	QP	Ρ	
8	2.5305	9.23	10.00	19.23	46.00	-26.77	AVG	Ρ	
9	6.2115	20.11	10.01	30.12	60.00	-29.88	QP	Ρ	
10	6.2115	9.28	10.01	19.29	50.00	-30.71	AVG	Р	
11	14.1495	18.34	10.02	28.36	60.00	-31.64	QP	Ρ	
12	14.1495	7.39	10.02	17.41	50.00	-32.59	AVG	Ρ	
Noto									
note. I	lote: Level = Reading + Factor Margin = Level - Limit								

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Conducted Emission Test Data

Test Mode: TM2/ CH Middle Comments: Neutral Line	
80.0 dBuV 70 60 50 1 3 5 5 5 5 5 5 5 5 5 5 5 5 5	
70 FCC Part15 CE-Class B_QP 60 FQC Part15 CE-Class B_AVG 50 FQC Part15 CE-Class B_AVG	
70 FQC Part15 CE-Class B_QP 60 FQC Part15 CE-Class B_QP 50 FQC Part15 CE-Class B_AVG	
60 50 1 3 5 5 5 5 5 5 5 5 5 5 5 5 5	7
50 1 3 5 5 5 5 5 5 5 5 5 5 5 5 5	_
50 1 3 5 5 5 5 5 5 5 5 5 5 5 5 5	
	-
	_
30 3 V V V V V V V V V V V V V V V V V V	
	peak
	AVG
).000
Francisco Desting Faster Level Lineit Marsin	
No.Frequency (MHz)Reading (dBuV)Factor (dB)Level (dBuV)Limit (dBuV)Margin (dBuV)DetectorP/FRemark	
1 0.1680 35.08 9.93 45.01 65.06 -20.05 QP P	
2 0.1680 13.96 9.93 23.89 55.06 -31.17 AVG P 3 0.2400 32.57 9.95 42.52 62.10 -19.58 OP P	

	(IVIHZ)	(aBuv)	(aB)	(aBuv)	(aBuv)	(aB)			
1	0.1680	35.08	9.93	45.01	65.06	-20.05	QP	Р	
2	0.1680	13.96	9.93	23.89	55.06	-31.17	AVG	Р	
3	0.2400	32.57	9.95	42.52	62.10	-19.58	QP	Р	
4	0.2400	9.66	9.95	19.61	52.10	-32.49	AVG	Р	
5 *	0.7485	30.75	10.01	40.76	56.00	-15.24	QP	Р	
6	0.7485	14.40	10.01	24.41	46.00	-21.59	AVG	Р	
7	2.4900	18.26	10.02	28.28	56.00	-27.72	QP	Р	
8	2.4900	9.53	10.02	19.55	46.00	-26.45	AVG	Р	
9	4.3439	19.99	10.01	30.00	56.00	-26.00	QP	Р	
10	4.3439	10.42	10.01	20.43	46.00	-25.57	AVG	Р	
11	13.2990	18.32	10.05	28.37	60.00	-31.63	QP	Ρ	
12	13.2990	7.52	10.05	17.57	50.00	-32.43	AVG	Р	

Note: Level = Reading + Factor

```
Margin = Level - Limit
```

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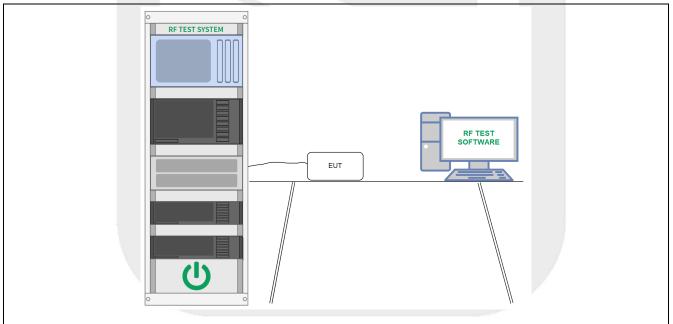


5.3 Occupied Bandwidth

5.3.1 Test Requirement

Test Requirement	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Limit:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method	ANSI C63.10-2020, section 6.9.2 Occupied bandwidth—relative measurement procedure

5.3.2 Test Setup Diagram



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5.3.3 Test Procedure

a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW.
b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement.

c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2.

d) Steps a) through c) might require iteration to adjust within the specified tolerances.

e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the

reference value.

f) Set detection mode to peak and trace mode to maxhold.

g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value).

h) Determine the "-xx dB down amplitude" using [(reference value) -xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.

i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j).

j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB down amplitude" determined in step h). If a marker is below this "-xx dB down amplitude" value, then it shall be as close as possible to this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the "-xx dB down amplitude" determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading at this point is the specified emission bandwidth.

k)The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

5.3.4 Test Data

PASS.

Please refer to Annex D for details.

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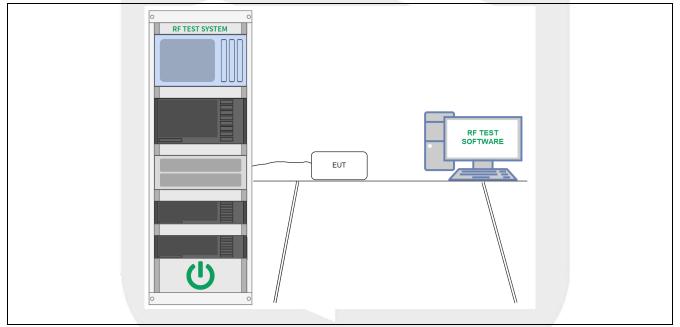


5.4 Maximum Conducted Output Power

5.4.1 Test Requirement

Test Requirement	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the
	2400-2483.5 MHz band: 0.125 watts.
Test Limit:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method	ANSI C63.10-2020, section 7.8.5 Output power test procedure for frequency-hopping spread-spectrum (FHSS) devices

5.4.2 Test Setup Diagram



5.4.3 Test Procedure

This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test:

a) Use the following spectrum analyzer settings:

- 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel.
- 2) RBW > 20 dB bandwidth of the emission being measured.
- 3) VBW >= RBW.
- 4) Sweep: Auto.
- 5) Detector function: Peak.
- 6) Trace: Max hold.
- b) Allow trace to stabilize.
- c) Use the marker-to-peak function to set the marker to the peak of the emission.

d) The indicated level is the peak output power, after any corrections for external attenuators and cables. A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

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5.4.4 Test Data PASS. Please refer to Annex D for details.



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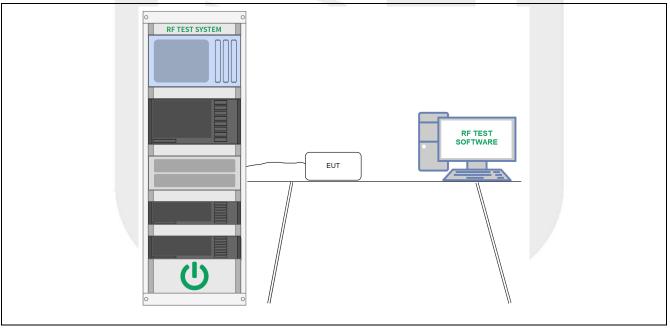


5.5 Carrier Frequency Separation

5.5.1 Test Requirement

Test Requirement	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Limit:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method	ANSI C63.10-2020, section 7.8.2 Carrier frequency separation

5.5.2 Test Setup Diagram



5.5.3 Test Procedure

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

a) Span: Wide enough to capture the peaks of two adjacent channels.

b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.

c) Video (or average) bandwidth (VBW) \geq RBW.

d) Sweep: Auto.

e) Detector function: Peak.

f) Trace: Max hold.

g) Allow the trace to stabilize.

Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

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5.5.4 Test Data PASS. Please refer to Annex D for details.



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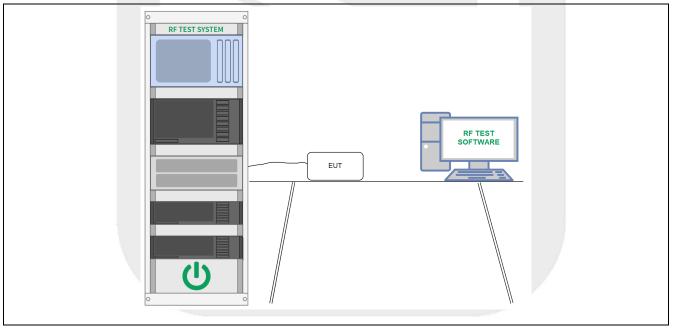
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5.6 Number of Hopping Frequencies

5.6.1 Test Requirement

Test Requirement	Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied bythe number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method	ANSI C63.10-2020, section 7.8.3 Number of hopping frequencies

5.6.2 Test Setup Diagram



5.6.3 Test Procedure

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen.

b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.

c) VBW ≥ RBW.

d) Sweep: Auto.

e) Detector function: Peak.

f) Trace: Max hold.

g) Allow the trace to stabilize.

It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.

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5.6.4 Test Data PASS. Please refer to Annex D for details.



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TRF No.: FCC Part 15.247_BT (B01)

Website: www.eu-test.com Tel: (86)-755-2357-9714 Email: Service@eu-test.com

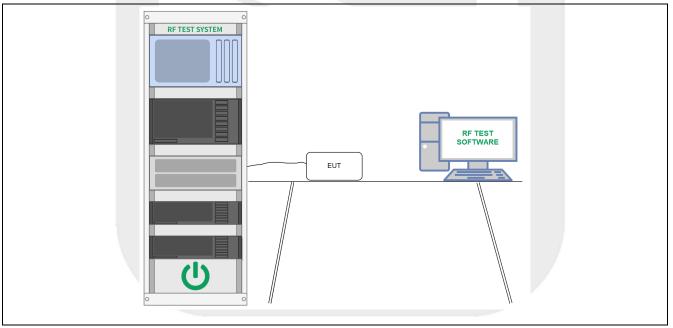


5.7 Time of Occupancy (Dwell Time)

5.7.1 Test Requirement

Test Requirement	Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method	ANSI C63.10-2020, section 7.8.4 Time of occupancy (dwell time)

5.7.2 Test Setup Diagram



5.7.3 Test Procedure

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

a) Span: Zero span, centered on a hopping channel.

b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel.

c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel.

d) Detector function: Peak.

e) Trace: Max hold.

Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time.

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Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation:

(Number of hops in the period specified in the requirements)=

(number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation.

The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT.

5.7.4 Test Data

PASS.

Please refer to Annex D for details.



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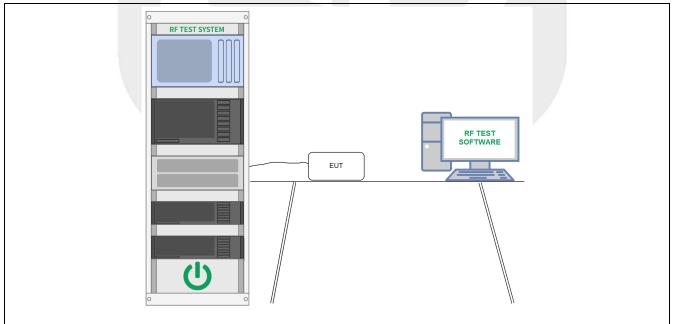
Website: www.eu-test.com

5.8 Emissions in Non-restricted Frequency Bands (Conducted)

5.8.1 Test Requirement

_	
Test Requirement	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method	ANSI C63.10-2020 Section 11.11 Emission in non-restricted frequency bands

5.8.2 Test Setup Diagram



5.8.3 Test Procedure

Conducted spurious emissions shall be measured for the transmit frequency and at the maximum transmit powers.

Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several

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plots are required to cover this entire span. RBW = 100 kHz VBW = 300 kHz Sweep = auto Detector function = peak Trace = max hold Allow the trace to stabilize

5.8.4 Test Data

PASS. Please refer to Annex D for details.



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5.9 Band Edge Emissions (Restricted frequency bands)

5.9.1 Test Requirement

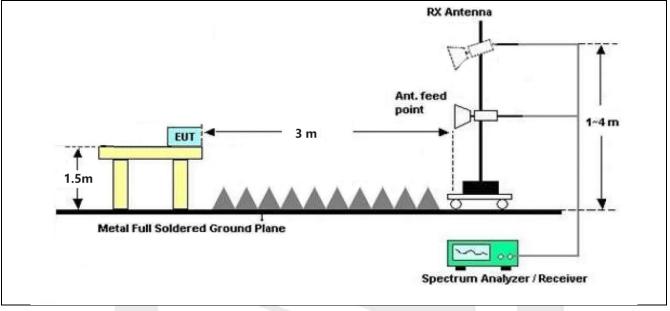
	In addition, radiated en	nissions which fall in the	restricted band	s, as defined in §						
Test Requirement	15.205(a), must also comply with the radiated emission limits specified in §									
	15.209(a)(see § 15.20	5(c)).								
	Frequency (MHz)	Field strength		Measurement						
		(microvolts/mete	r)	distance						
		(• /	(meters)						
	0.009-0.490	2400/F(kHz)		300						
	0.490-1.705	2400/F(kHz)	And the second second	30						
	1.705-30.0	30		30						
	30-88	100 **		3						
	88-216	150 **		3						
	216-960	200 **		3						
	Above 960	500		3						
		n paragraph (g), fundam								
	54-72 MHz, 76-88 MHz		806 MHz. Howev	ver, operation withir						
	MHz	MHz	MHz	GHz						
	0.090-0.110	16.42-16.423	399.9-410	4.5-5.15						
	0.495-0.505	16.69475-16.69525	608-614	5.35-5.46						
	2.1735-2.1905	16.80425-16.80475	960-1240	7.25-7.75						
	4.125-4.128	25.5-25.67	1300-1427	8.025-8.5						
	4.17725-4.17775	37.5-38.25	1435-1626.5	9.0-9.2						
Fest Limit	4.20725-4.20775	73-74.6	1645.5-1646.5	9.3-9.5						
	6.215-6.218	74.8-75.2	1660-1710	10.6-12.7						
	6.26775-6.26825	108-121.94	1718.8-1722.2	13.25-13.4						
	6.31175-6.31225	123-138	2200-2300	14.47-14.5						
	8.291-8.294	149.9-150.05	2310-2390	15.35-16.2						
	8.362-8.366	156.52475-156.52525	2483.5-2500	17.7-21.4						
	8.37625-8.38675	156.7-156.9	2690-2900	22.01-23.12						
	8.41425-8.41475	162.0125-167.17	3260-3267	23.6-24.0						
	12.29-12.293 12.51975-12.52025 12.57675-12.57725 13.36-13.41	167.72-173.2 240-285 322-335.4	3332-3339 3345.8-3358 3600-4400	31.2-31.8 36.43-36.5						
	Note: 1) Field Strength (dBμV/m) = 20*log[Field Strength (μV/m)].									
	2) In the emission table	2) In the emission tables above, the tighter limit applies at the band edges.								
	3) For Above 1000 MHz, the emission limit in this paragraph is based on									
	,	measurement instrumentation employing an average detector, measurement using								
		peak detector function, o	-							
	maximum permitted av									
	-	-	armonica:							
		z, limit field strength of h								
		and 74dBuV/m@3m (PK	.).							
Test Method	ANSI C63.10-2020 sec	ction 6.6.4								

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5.9.2 Test Setup Diagram



5.9.3 Test Procedure

The measurement frequency range is from 9 kHz to the 10th harmonic of the fundamental frequency. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented. The power of the EUT transmitting frequency should be ignored. All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \ge 1$ GHz, 100 kHz for f < 1 GHz VBW \ge RBW Sweep = auto

Detector function = peak

Trace = max hold.

5.9.4 Test Data

PASS. Please refer to the following pages.

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Band-edge Emissions (Radiated)

Test Mode: GFSK					CH Low: 2402 MHz			
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
Н	2310.00	45.10	-2.81	42.29	74.00	-31.71	PK	PASS
Н	2390.00	48.66	-2.69	45.97	74.00	-28.03	PK	PASS
Н	**2400.00	63.45	-2.68	60.77	74.00	-13.23	PK	PASS
V	2310.00	47.04	-2.81	44.23	74.00	-29.77	PK	PASS
V	2390.00	48.54	-2.69	45.85	74.00	-28.15	PK	PASS
V	**2400.00	62.68	-2.68	60.00	74.00	-14.00	PK	PASS
Н	2310.00	34.71	-2.81	31.90	54.00	-22.10	AV	PASS
Н	2390.00	35.70	-2.69	33.01	54.00	-20.99	AV	PASS
Н	**2400.00	49.68	-2.68	47.00	54.00	-7.00	AV	PASS
V	2310.00	35.33	-2.81	32.52	54.00	-21.48	AV	PASS
V	2390.00	39.21	-2.69	36.52	54.00	-17.48	AV	PASS
V	**2400.00	49.49	-2.68	46.81	54.00	-7.19	AV	PASS

Test Mode: GFSK					CH High: 2480 MHz			
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
Н	**2483.50	48.35	-2.56	45.79	74.00	-28.21	PK	PASS
Н	2500.00	51.41	-2.54	48.87	74.00	-25.13	PK	PASS
V	**2483.50	48.14	-2.56	45.58	74.00	-28.42	PK	PASS
V	2500.00	49.41	-2.54	46.87	74.00	-27.13	PK	PASS
Н	**2483.50	36.98	-2.56	34.42	54.00	-19.58	AV	PASS
Н	2500.00	42.31	-2.54	39.77	54.00	-14.23	AV	PASS
V	**2483.50	39.74	-2.56	37.18	54.00	-16.82	AV	PASS
V	2500.00	40.34	-2.54	37.80	54.00	-16.20	AV	PASS

Remark:

1. Emission Level = Reading + Factor, Margin= Emission Level – Limit.

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Band Edge Emissions (Restricted frequency bands):

Test M	lode: π/4DQF	PSK		CH Low: 2402 MHz				
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
Н	2310.00	46.91	-2.81	44.10	74.00	-29.90	PK	PASS
Н	2390.00	47.37	-2.69	44.68	74.00	-29.32	PK	PASS
Н	**2400.00	61.75	-2.68	59.07	74.00	-14.93	PK	PASS
V	2310.00	46.62	-2.81	43.81	74.00	-30.19	PK	PASS
V	2390.00	49.89	-2.69	47.20	74.00	-26.80	PK	PASS
V	**2400.00	65.32	-2.68	62.64	74.00	-11.36	PK	PASS
Н	2310.00	32.62	-2.81	29.81	54.00	-24.19	AV	PASS
Н	2390.00	36.10	-2.69	33.41	54.00	-20.59	AV	PASS
Н	**2400.00	49.57	-2.68	46.89	54.00	-7.11	AV	PASS
V	2310.00	33.59	-2.81	30.78	54.00	-23.22	AV	PASS
V	2390.00	35.85	-2.69	33.16	54.00	-20.84	AV	PASS
V	**2400.00	48.67	-2.68	45.99	54.00	-8.01	AV	PASS

Test N	/lode: π/4DQF	PSK		CH High: 2480 MHz				
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
Н	**2483.50	49.71	-2.56	47.15	74.00	-26.85	PK	PASS
Н	2500.00	52.65	-2.54	50.11	74.00	-23.89	PK	PASS
V	**2483.50	48.64	-2.56	46.08	74.00	-27.92	PK	PASS
V	2500.00	52.22	-2.54	49.68	74.00	-24.32	PK	PASS
Н	**2483.50	38.65	-2.56	36.09	54.00	-17.91	AV	PASS
Н	2500.00	41.46	-2.54	38.92	54.00	-15.08	AV	PASS
V	**2483.50	37.86	-2.56	35.30	54.00	-18.70	AV	PASS
V	2500.00	41.62	-2.54	39.08	54.00	-14.92	AV	PASS

Remark:

1. Emission Level = Reading + Factor, Margin= Emission Level – Limit.

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Band Edge Emissions (Restricted frequency bands):

Test N	/lode: 8DPSK			CH Low: 2402 MHz				
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
Н	2310.00	43.76	-2.81	40.95	74.00	-33.05	PK	PASS
Н	2390.00	50.11	-2.69	47.42	74.00	-26.58	PK	PASS
Н	**2400.00	63.49	-2.68	60.81	74.00	-13.19	PK	PASS
V	2310.00	44.75	-2.81	41.94	74.00	-32.06	PK	PASS
V	2390.00	47.24	-2.69	44.55	74.00	-29.45	PK	PASS
V	**2400.00	62.82	-2.68	60.14	74.00	-13.86	PK	PASS
Н	2310.00	34.88	-2.81	32.07	54.00	-21.93	AV	PASS
Н	2390.00	37.04	-2.69	34.35	54.00	-19.65	AV	PASS
Н	**2400.00	48.43	-2.68	45.75	54.00	-8.25	AV	PASS
V	2310.00	34.67	-2.81	31.86	54.00	-22.14	AV	PASS
V	2390.00	38.83	-2.69	36.14	54.00	-17.86	AV	PASS
V	**2400.00	48.62	-2.68	45.94	54.00	-8.06	AV	PASS

Test N	/lode: 8DPSK			CH High: 2480 MHz				
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
Н	**2483.50	49.10	-2.56	46.54	74.00	-27.46	PK	PASS
Н	2500.00	51.62	-2.54	49.08	74.00	-24.92	PK	PASS
V	**2483.50	49.00	-2.56	46.44	74.00	-27.56	PK	PASS
V	2500.00	52.78	-2.54	50.24	74.00	-23.76	PK	PASS
Н	**2483.50	38.52	-2.56	35.96	54.00	-18.04	AV	PASS
Н	2500.00	42.68	-2.54	40.14	54.00	-13.86	AV	PASS
V	**2483.50	39.09	-2.56	36.53	54.00	-17.47	AV	PASS
V	2500.00	41.49	-2.54	38.95	54.00	-15.05	AV	PASS

Remark:

1. Emission Level = Reading + Factor, Margin= Emission Level – Limit.

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5.10 Radiated Spurious Emission

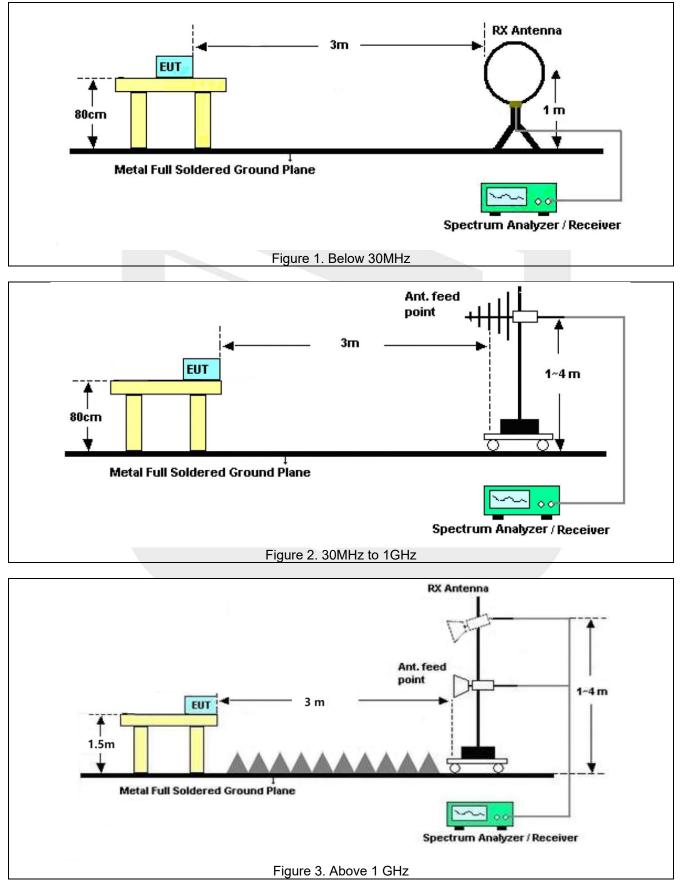
5.10.1Test Requirement

	In addition, radiated emissio	ns which fall in the restricted band	ls, as defined in §					
Test Requirement	15.205(a), must also comply with the radiated emission limits specified in §							
	15.209(a)(see § 15.205(c)).							
	Frequency (MHz)	Field strength	Measurement					
		(microvolts/meter)	distance					
			(meters)					
	0.009-0.490	2400/F(kHz)	300					
	0.490-1.705	24000/F(kHz)	30					
	1.705-30.0	30	30					
	30-88	100 **	3					
	88-216	150 **	3					
	216-960	200 **	3					
	Above 960	500	3					
	** Except as provided in paragraph (g), fundamental emissions from intentional							
	radiators operating under this section shall not be located in the frequency bands							
Test Limit	54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within							
	these frequency bands is permitted under other sections of this part, e.g.,							
	§§ 15.231 and 15.241.							
	Note:							
	1) Field Strength (dB μ V/m) = 20*log[Field Strength (μ V/m)]. 2) In the emission tables above, the tighter limit applies at the band edges.							
	3) For Above 1000 MHz, the emission limit in this paragraph is based on							
		on employing an average detector						
		detector function, corresponding t						
			0 200B above the					
	maximum permitted average							
		t field strength of harmonics:						
	54dBuV/m@3m (AV) and 74							
Test Method	ANSI C63.10-2020 section 6	5.6.4						
	Radiated emissions tests							

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5.10.2Test Setup Diagram



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5.10.3Test Procedure

The measurement frequency range is from 9 kHz to the 10th harmonic of the fundamental frequency. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power.

Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

The power of the EUT transmitting frequency should be ignored.

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW =1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as: RBW = 9KHz, VBW =30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as: RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as: RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple. RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

For measurement below 1GHz, If the emission level of the EUT measured by the peak detector is 3 dB lower than the applicable limit, the peak emission level will be reported, Otherwise, the emission measurement will be repeated using the quasi-peak detector and reported.

5.10.4Test Data

PASS.

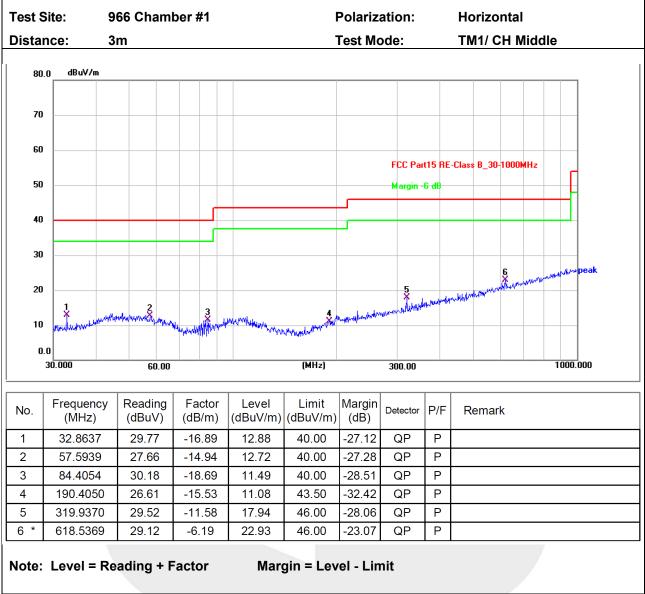
During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation Middle channel(TX Only) which is the worst case, only the worst case is recorded in the report.

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

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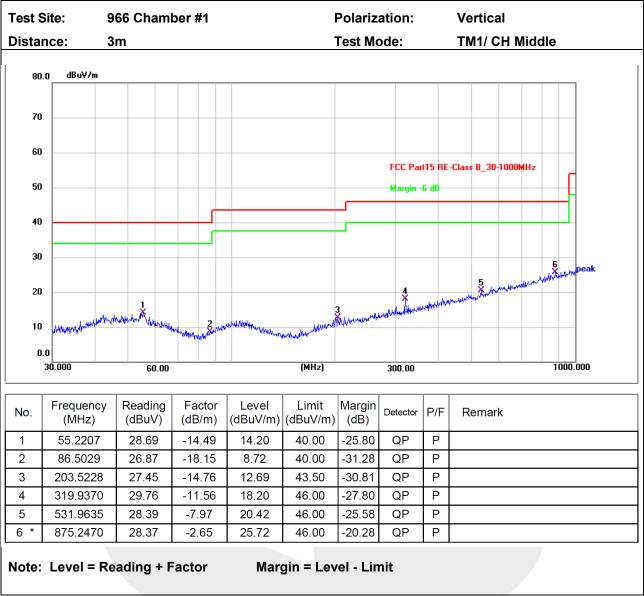
Radiated Emission Test Data (30-1000MHz)



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Radiated Emission Test Data (30-1000MHz)



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Radiated Spurious Emission (1GHz-25GHz)

Test Mode: GFSK					CH Low: 2402 MHz			
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
V	4804.18	40.08	4.68	44.76	74.00	-29.25	PK	PASS
V	7206.38	34.07	9.84	43.91	74.00	-30.10	PK	PASS
V	9608.88	29.91	13.17	43.08	74.00	-30.93	PK	PASS
V	12010.19	*	*	*	74.00	*	PK	PASS
V	14412.68	*	*	*	74.00	*	PK	PASS
V	16814.94	*	*	*	74.00	*	PK	PASS
Н	4804.54	40.10	4.68	44.78	74.00	-29.23	PK	PASS
Н	7206.94	34.15	9.84	43.99	74.00	-30.01	PK	PASS
Н	9608.70	29.47	13.17	42.64	74.00	-31.36	PK	PASS
Н	12010.96	*	*	*	74.00	*	PK	PASS
Н	14412.22	*	*	*	74.00	*	PK	PASS
Н	16814.34	*	*	*	74.00	*	PK	PASS
V	4804.69	32.71	4.68	37.39	54.00	-16.62	AV	PASS
V	7206.27	23.08	9.84	32.92	54.00	-21.08	AV	PASS
V	9608.35	17.50	13.17	30.67	54.00	-23.33	AV	PASS
V	12010.58	*	*	*	54.00	*	AV	PASS
V	14412.78	*	*	*	54.00	*	AV	PASS
V	16814.26	*	*	*	54.00	*	AV	PASS
Н	4804.41	30.89	4.68	35.57	54.00	-18.44	AV	PASS
Н	7206.94	24.08	9.84	33.92	54.00	-20.08	AV	PASS
Н	9608.70	18.20	13.17	31.37	54.00	-22.63	AV	PASS
Н	12010.96	*	*	*	54.00	*	AV	PASS
Н	14412.22	*	*	*	54.00	*	AV	PASS
Н	16814.34	*	*	*	54.00	*	AV	PASS

Remark:

1. Emission Level = Reading + Factor, Margin= Emission Level – Limit.

2. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

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Radiated Spurious Emission (1GHz-25GHz)

Test Mode: GFSK					CH Middle: 2441 MHz			
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
V	4882.20	42.10	4.92	47.02	74.00	-26.98	PK	PASS
V	7323.20	35.95	9.83	45.78	74.00	-28.22	PK	PASS
V	9764.20	30.28	13.22	43.50	74.00	-30.51	PK	PASS
V	12205.52	*	*	*	74.00	*	PK	PASS
V	14646.31	*	*	*	74.00	*	PK	PASS
V	17087.81	*	*	*	74.00	*	PK	PASS
Н	4882.85	42.51	4.92	47.43	74.00	-26.58	PK	PASS
Н	7323.28	35.82	9.83	45.65	74.00	-28.36	PK	PASS
Н	9764.09	29.73	13.22	42.95	74.00	-31.05	PK	PASS
Н	12205.72	*	*	*	74.00	*	PK	PASS
Н	14646.90	*	*	*	74.00	*	PK	PASS
Н	17087.93	*	*	*	74.00	*	PK	PASS
V	4882.19	32.02	4.92	36.94	54.00	-17.07	AV	PASS
V	7323.43	22.45	9.83	32.28	54.00	-21.72	AV	PASS
V	9764.07	18.69	13.22	31.91	54.00	-22.09	AV	PASS
V	12205.38	*	*	*	54.00	*	AV	PASS
V	14646.32	*	*	*	54.00	*	AV	PASS
V	17087.42	*	*	*	54.00	*	AV	PASS
Н	4882.85	31.23	4.92	36.15	54.00	-17.85	AV	PASS
Н	7323.28	24.91	9.83	34.74	54.00	-19.27	AV	PASS
Н	9764.09	17.94	13.22	31.16	54.00	-22.84	AV	PASS
Н	12205.72	*	*	*	54.00	*	AV	PASS
Н	14646.90	*	*	*	54.00	*	AV	PASS
Н	17087.93	*	*	*	54.00	*	AV	PASS

Remark:

1. Emission Level = Reading + Factor, Margin= Emission Level – Limit.

2. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

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Radiated Spurious Emission (1GHz-25GHz)

Test Mode: GFSK					CH High: 2480 MHz			
Pol.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Emission level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector Type	Result
V	4960.30	41.72	5.17	46.89	74.00	-27.11	PK	PASS
V	7440.79	34.85	9.83	44.68	74.00	-29.32	PK	PASS
V	9920.25	30.38	13.27	43.65	74.00	-30.35	PK	PASS
V	12400.86	*	*	*	74.00	*	PK	PASS
V	14880.95	*	*	*	74.00	*	PK	PASS
V	17360.52	*	*	*	74.00	*	PK	PASS
Н	4960.81	42.19	5.17	47.36	74.00	-26.65	PK	PASS
Н	7440.90	35.29	9.83	45.12	74.00	-28.89	PK	PASS
Н	9920.71	28.83	13.27	42.10	74.00	-31.90	PK	PASS
Н	12400.16	*	*	*	74.00	*	PK	PASS
Н	14880.06	*	*	*	74.00	*	PK	PASS
Н	17360.07	*	*	*	74.00	*	PK	PASS
V	4960.78	30.87	5.17	36.04	54.00	-17.96	AV	PASS
V	7440.87	22.64	9.83	32.47	54.00	-21.53	AV	PASS
V	9920.61	19.02	13.27	32.29	54.00	-21.71	AV	PASS
V	12400.16	*	*	*	54.00	*	AV	PASS
V	14880.98	*	*	*	54.00	*	AV	PASS
V	17360.51	*	*	*	54.00	*	AV	PASS
Н	4960.81	30.73	5.17	35.90	54.00	-18.10	AV	PASS
Н	7440.90	22.43	9.83	32.26	54.00	-21.75	AV	PASS
Н	9920.71	18.78	13.27	32.05	54.00	-21.96	AV	PASS
Н	12400.16	*	*	*	54.00	*	AV	PASS
Н	14880.06	*	*	*	54.00	*	AV	PASS
Н	17360.07	*	*	*	54.00	*	AV	PASS

Remark:

1. Emission Level = Reading + Factor, Margin= Emission Level – Limit.

2. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

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ANNEX A TEST SETUP PHOTOS

Please refer to the document "8255EU012212W-AA.PDF"

ANNEX B EXTERNAL PHOTOS

Please refer to the document "8255EU012212W-AB.PDF"

ANNEX C INTERNAL PHOTOS

Please refer to the document "8255EU012212W-AC.PDF"

ANNEX D TEST DATA

Please refer to the document "8255EU012212W-AD.PDF"

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